## **SxX8BBS Series**

### EV Series 0.8 Amp Sensitive SCRs





#### **Main Features**

Symbol	Value	Unit
I <sub>T(RMS)</sub>	0.8	А
$V_{DRM}/V_{RRM}$	600	V
I <sub>GT</sub>	200	μΑ

#### **Description**

This new sensitive SCR component series offers 600V  $V_{\text{DRM}}$  and 0.8A  $I_{\text{T(RMS)}}$  capability in the smallest package size in the industry, SOT23. It is specifically designed for GFCI (Ground Fault Circuit Interrupter) applications. All SCRs junctions are glass-passivated to ensure long term reliability and parametric stability.

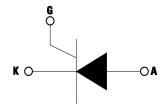
#### **Features**

- Very compact SOT23 SMT package
- Surge current capability up to 12A @ 60Hz
- Blocking voltage (V<sub>DRM</sub> / V<sub>RRM</sub>) capability - up to 600V
- High dv/dt noise immunity
- Improved turn-off time (t<sub>q</sub>) < 25 µsec
- Sensitive gate for direct microprocessor interface
- RoHS compliant and Halogen-Free

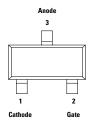
### **Applications**

The SxX8BBS series is specifically designed for GFCI (Ground Fault Circuit Interrupter) and applications.

#### **Schematic Symbol**



#### Pin out



#### **Absolute Maximum Ratings**

Symbol	Parameter			Value	Unit
$V_{DSM}/V_{RSM}$	Peak non-repetitive blocking voltage	Pw=100μs		700	V
I <sub>T(RMS)</sub>	RMS on-state current (full sine wave)		$T_{\rm C} = 80^{\circ}{\rm C}$	0.8	А
I <sub>T(AV)</sub>	Average on-state current		$T_{\rm C} = 80^{\circ}{\rm C}$	0.51	А
	Non repetitive surge peak on-state current		f= 50Hz	10	А
TSM	(Single cycle, $T_J$ initial = 25°C)		f= 60Hz	12	А
2 <sub>†</sub>	I²t Value for fusing	$t_p = 10 \text{ ms}$	f= 50 Hz	0.5	A <sup>2</sup> s
1 (	i t value for fushing	$t_p = 8.3 \text{ ms}$	f= 60 Hz	0.6	A <sup>2</sup> s
di/dt	Critical rate of rise of on-state current $I_{\rm G}$ = 10mA	60 Hz	$T_J = 125^{\circ}C$	80	A/µs
I <sub>GM</sub>	Peak Gate Current	$t_{p} = 20 \ \mu s$	$T_J = 125^{\circ}C$	1.0	А
$P_{G(AV)}$	Average gate power dissipation	_	$T_J = 125^{\circ}C$	0.1	W
T <sub>stg</sub>	Storage junction temperature range	_	_	-40 to 150	°C
T,	Operating junction temperature range		_	-40 to 125	°C



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#### **Electrical Characteristics** ( $T_1 = 25$ °C, unless otherwise specified)

Symbol	Description	Test Conditions	Limit	Value	Unit
	DC Cata Trigger Current	V - 6V P - 100 O	MIN.	50	μA
I <sub>GT</sub>	DC Gate Trigger Current	$V_D = 6V$ , $R_L = 100 \Omega$	MAX.	200	μΑ
$V_{\rm GT}$	DC Gate Trigger Voltage	$V_D = 6V$ , $R_L = 100 \Omega$	MAX.	0.8	V
$V_{GRM}$	Peak Reverse Gate Voltage	$I_{RG} = 10\mu A$	MIN.	8	V
I <sub>H</sub>	Holding Current	Initial Current = 20mA	MAX.	10	mA
(dv/dt)s	Critical Rate-of-Rise of Off-State Voltage	$T_J = 125^{\circ}\text{C}$ $V_D = 67\% V_{DRM} / V_{RRM}$ Exp. Waveform, $R_{GK} = 1 \text{ k}\Omega$	MIN.	50	V/µs
$V_{gD}$	Gate Non-Trigger Voltage	$V_{D} = V_{DRM'} R_{GK} = 1 k\Omega$ $T_{J} = 125^{\circ}C$	MIN.	0.2	V
t <sub>q</sub>	Turn-Off Time	I <sub>T</sub> =0.5A	MAX.	25	μs
t <sub>gt</sub>	Turn-On Time	$I_{g}$ =10mA,Pw= 15µsec, $I_{T}$ = 1.6A(pk)	TYP.	2.0	μs

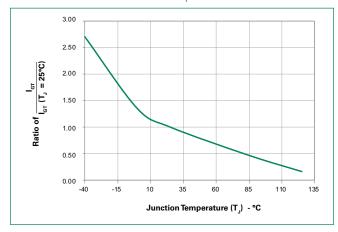
#### **Static Characteristics** (T<sub>J</sub> = 25°C, unless otherwise specified)

Symbol	Description	Test Conditions	Limit	Value	Unit
$V_{TM}$	Peak On-State Voltage	$I_{TM} = 1.6A (pk)$	MAX.	1.70	V
1 //	$V_{DRM}/V_{RRM}$	$T_{_{\rm J}}=25^{\circ}{\rm C}$	MAX.	5	μΑ
I <sub>DRM</sub> /I <sub>RRM</sub>		T <sub>1</sub> = 125°C	MAX.	100	μΑ

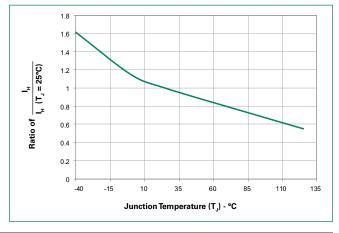
#### **Thermal Resistances**

Symbol	Description	Value	Unit
$R_{\Theta(JC)}$	Junction to case (AC)	45	°C/W
$R_{\Theta(J-A)}$	Junction to ambient	220	°C/W

**Figure 1:**Normalized DC Gate Trigger Current vs.
Junction Temperature



**Figure 2:**Normalized DC Holding Current vs.
Junction Temperature





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**Figure 3:**Normalized DC Gate Trigger Voltage vs. Junction Temperature

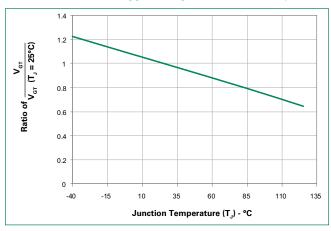
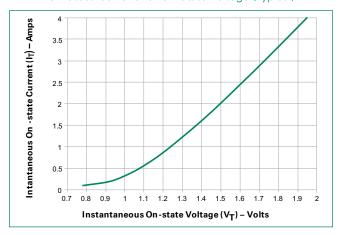
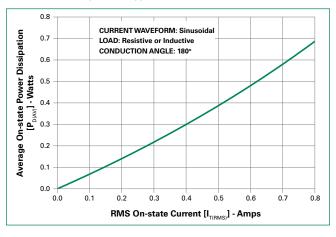


Figure 4:
On-State Current vs. On-State Voltage (Typical)



**Figure 5:**Power Dissipation (Typical) vs. RMS On-State Current



**Figure 6:**Maximum Allowable Case Temperature vs. On-State Current

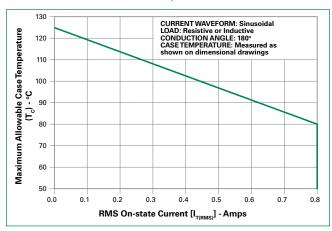
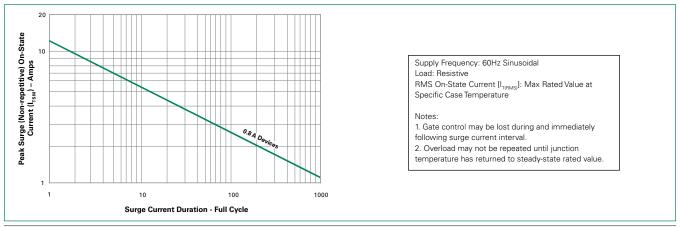


Figure 7: Surge Peak On-State Current vs. Number of Cycles





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Figure 8: Static dv/dt vs. RGK vs. Junction Temperature

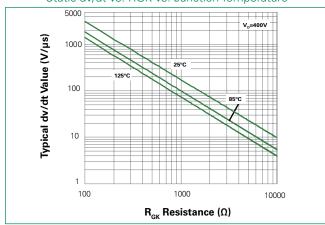
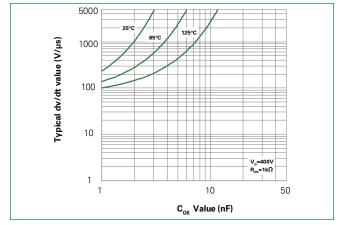
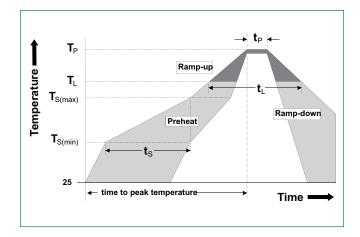


Figure 9: Static dv/dt vs. CGK vs. Juntion Temperature



#### **Soldering Parameters**

Reflow Condition		Pb – Free assembly	
	- Temperature Min (T <sub>s(min)</sub> )	150°C	
Pre Heat	-Temperature Max (T <sub>s(max)</sub> )	200°C	
	-Time (min to max) (t <sub>s</sub> )	60 – 120 secs	
Average ram	p up rate (Liquidus Temp) (T <sub>L</sub> ) to peak	3°C/second max	
T <sub>S(max)</sub> to T <sub>L</sub> - Ramp-up Rate		5°C/second max	
Reflow	- Temperature (T <sub>L</sub> ) (Liquidus)	217°C	
Retiow	-Time (min to max) (t <sub>s</sub> )	60 – 150 seconds	
Peak Tempera	ature (T <sub>P</sub> )	260 <sup>+0/-5</sup> °C	
Time within	5°C of actual peak Temperature (t <sub>p</sub> )	30 seconds	
Ramp-down Rate		6°C/second max	
Time 25°C to peak Temperature (T <sub>p</sub> )		8 minutes Max.	
Do not exceed		260°C	



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#### **Physical Specifications**

Terminal Finish	100% Matte Tin-plated.
Body Material	UL Recognized compound meeting flammability rating V-0.
Lead Material	Copper Alloy

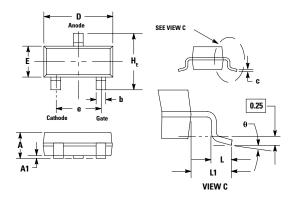
#### **Design Considerations**

Careful selection of the correct component for the application's operating parameters and environment will go a long way toward extending the operating life of the Thyristor. Good design practice should limit the maximum continuous current through the main terminals to 75% of the component rating. Other ways to ensure long life for a power discrete semiconductor are proper heat sinking and selection of voltage ratings for worst case conditions. Overheating, overvoltage (including dv/dt), and surge currents are the main killers of semiconductors. Correct mounting, soldering, and forming of the leads also help protect against component damage.

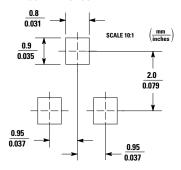
#### Reliability/Environmental Tests

Test	Specifications and Conditions
HTRB (AC Blocking)	MIL-STD-750, M-1040, Cond A Applied Peak AC voltage @ V <sub>DRM</sub> @ 125°C for 1008 hours
Temperature Cycling	MIL-STD-750, M-1051, 100 cycles; -55°C to +150°C; 15-min dwell-time
H3TRB	EIA / JEDEC, JESD22-A101 1008 hours; 160V - DC: 85°C; 85% rel humidity
UHAST	ESD22-A118, 96hours, 130°C, 85%RH
Resistance to Solder Heat	MIL-STD-750 Method 2031, 260°C, 10s
Solderability	ANSI/J-STD-002, category 3, Test A
Moisture Sensitivity Level	Level 1, JEDEC-J-STD-020D

#### **Dimensions - SOT-23**



#### SOLDERING FOOTPRINT



#### Millimeters Inches Dimensions Min Min Тур Max Тур Max 0.04 0.04 Α 0.04 0.89 1.02 1.12 Α1 0.00 0.00 0.01 0.01 0.10 0.15 0.02 0.02 0.02 0.38 b 0.46 0.51 0.00 0.01 0.01 0.08 0.13 0.18 C D 0.11 0.11 0.12 2.80 2.90 3.04 Ε 0.05 0.05 0.06 1.30 1.40 1.19 0.07 0.08 0.08 1.78 1.91 2.06 L 0.02 0.02 0.02 0.40 0.49 0.60 L1 0.01 0.02 0.03 0.36 0.53 0.74 Н 0.08 0.09 2.30 0.10 2.10 2.64 0° 10° 0° θ 10°

#### **Product Selector**

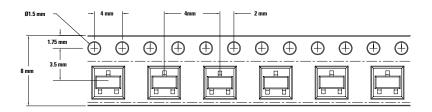
Part Number	Voltage 600V	Gate Sensitivity	Package
S6X8BBS	X	200 μΑ	SOT-23

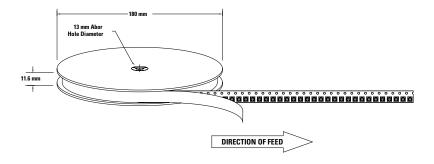
#### **Packing Options**

Part Number	Marking	Weight	Packing Mode	Base Quantity
S6X8BBSRP	6X8	0.01g	Tape & Reel	3000

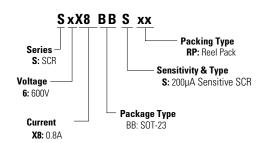


#### **SOT-23 Reel Pack (RP) Specifications**





#### **Part Numbering System**



#### **Part Marking System**



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